TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSV)

# 2SK2889

# Chopper Regulator, DC-DC Converter and Motor Drive Applications

 $\begin{array}{ll} \bullet & \text{Low drain-source ON resistance} & : R_{DS \; (ON)} = 0.54 \; \Omega \; (typ.) \\ \bullet & \text{High forward transfer admittance} & : |Y_{fs}| = 9.0 \; S \; (typ.) \\ \bullet & \text{Low leakage current} & : I_{DSS} = 100 \; \mu A \; (max) \; (V_{DSS} = 600 \; V) \\ \bullet & \text{Enhancement mode} & : V_{th} = 2.0 \sim 4.0 \; V \; (V_{DS} = 10 \; V, \; I_{D} = 1 \; mA) \\ \end{array}$ 

#### **Absolute Maximum Ratings (Ta = 25°C)**

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	600	V	
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		$V_{DGR}$	600	٧	
Gate-source voltage		$V_{GSS}$	±30	٧	
Drain current	DC (Note 1)	I <sub>D</sub>	10	Α	
	Pulse (Note 1)	I <sub>DP</sub>	40	Α	
Drain power dissipatio	n (Tc = 25°C)	$P_{D}$	100	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	363	mJ	
Avalanche current		I <sub>AR</sub>	10	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	10	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	1.25	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	83.3	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

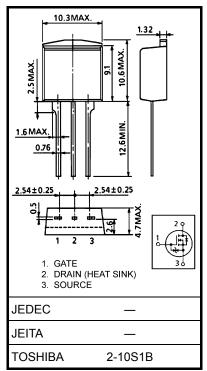
Note 2:  $V_{DD} = 90 \text{ V}$ ,  $T_{Ch} = 25^{\circ}\text{C}$  (initial), L = 6.36 mH,  $R_G = 25 \Omega$ ,

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

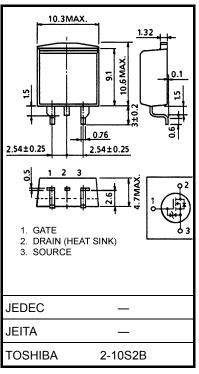
This transistor is an electrostatic-sensitive device.

Please handle with caution.

Unit: mm



Weight: 1.5 g (typ.)



Weight: 1.5 g (typ.)



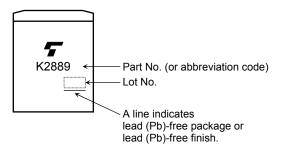
## **Electrical Characteristics (Ta = 25°C)**

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Gate-source bro	eakdown voltage	V (BR) GSS	$I_G = \pm 10 \mu A, V_{DS} = 0 V$	±30	_	_	V
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	600	_	_	V
Gate threshold v	/oltage	$V_{th}$	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A	_	0.54	0.75	Ω
Forward transfe	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 5 A	3.0	9.0	_	S
Input capacitano	ce	C <sub>iss</sub>		_	2040	_	
Reverse transfe	r capacitance	C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		230	_	pF
Output capacitance		Coss		_	590	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS}$ $V_{OV}$ $V_{OUT}$ $V_{DD}$ $V_{DD}$	_	22	_	
	Turn-on time	t <sub>on</sub>		-	58	_	ne
	Fall time	t <sub>f</sub>		_	36	_	ns
	Turn-off time	t <sub>off</sub>	Duty $\leq 1\%$ , $t_{\mathbf{W}} = 10 \mu \text{s}$	_	190	_	
Total gate charg plus gate-drain)	Total gate charge (gate-source plus gate-drain) Qg		_	45	_		
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		25	_	nC
Gate-drain ("miller") Charge		Q <sub>gd</sub>			20	_	

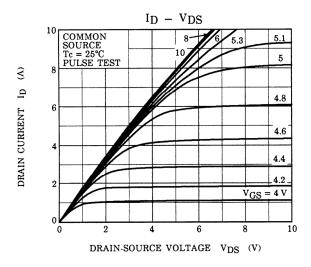
### **Source-Drain Ratings and Characteristics (Ta = 25°C)**

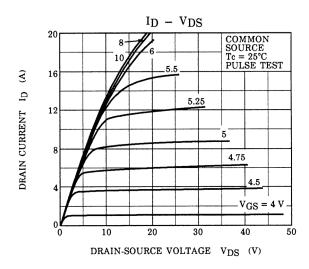
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	10	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	40	Α
Forward voltage (diode)	$V_{DSF}$	I <sub>DR</sub> = 10 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 10 A, V <sub>GS</sub> = 0 V	1	1300	1	ns
Reverse recovery charge	Qrr	dI <sub>DR</sub> / dt = 100 A / μs		16		nC

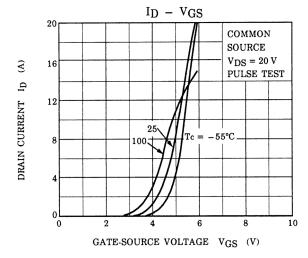
### Marking

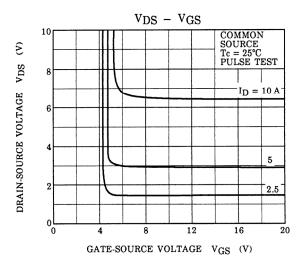


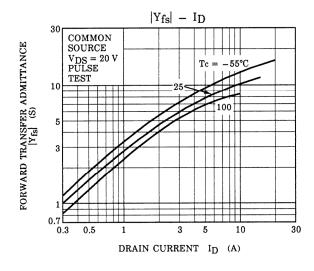
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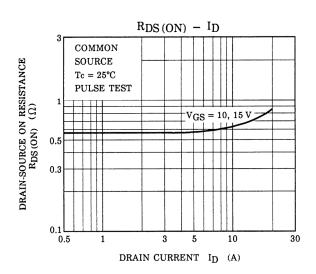




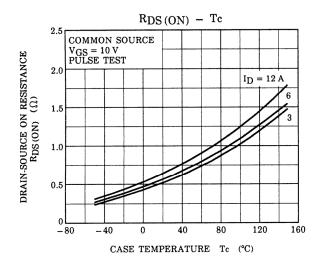


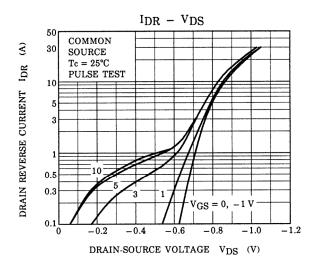


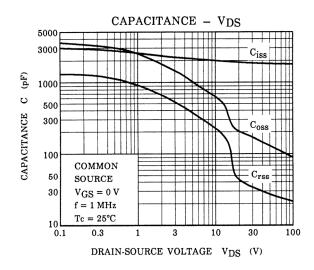


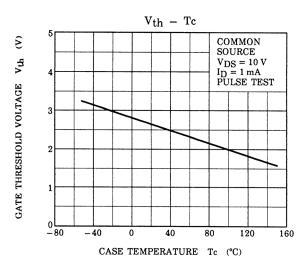


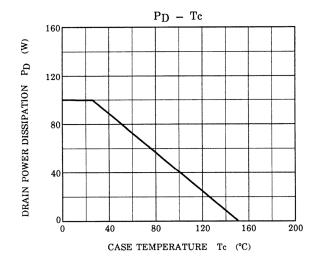
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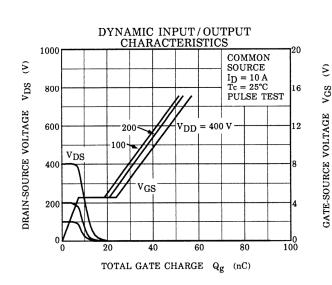


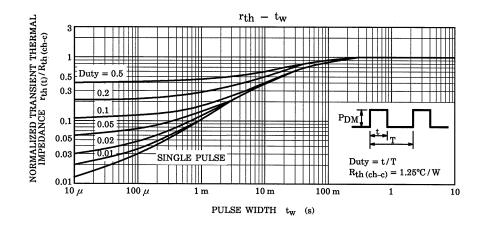


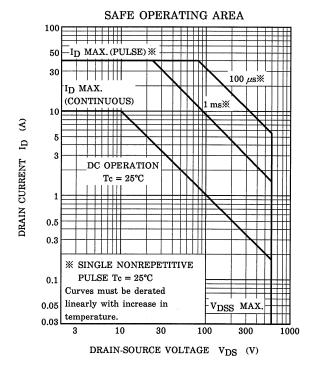


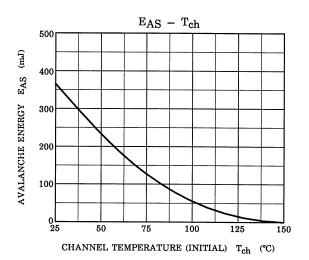


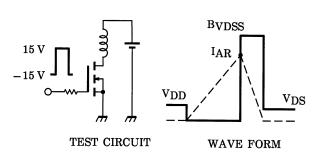












$$R_G$$
 = 25  $\Omega$   
 $V_{DD}$  = 90 V, L = 6.36 mH

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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